Special Issue

On IoT Security, Privacy and Quality

Message from the Guest Editors

Internet of Things (IoT) has evolved into a wellrecognized term for solutions used across many industry segments. Despite the popularity, there are still multiple challenges. IoT is often seen as a network of connected smart devices providing a lot of data. Still, it can also become a nightmare when it comes to perspectives as security, privacy, and quality. This Special Issue considers these three perspectives that deserve special attention. It aims for novel works, reviews, and comparative studies focusing on one of the core issue aspects. It welcomes novel approaches with promising preliminary results or work with a multidisciplinary span, including Big Data, blockchain, machine learning, architecture reconstruction, architectural degradation, and cloud-computing, among others. Topics of interest include but are not limited to thefollowing:

- IoT
- Security
- Privacy
- Quality

Guest Editors

Dr. Tomas Cerny

Prof. Dr. Dongwan Shin

Prof. Dr. Jiman Hong

Deadline for manuscript submissions

closed (15 August 2022)



Sensors

an Open Access Journal by MDPI

Impact Factor 3.5 CiteScore 8.2 Indexed in PubMed



mdpi.com/si/80665

Sensors
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
sensors@mdpi.com

mdpi.com/journal/ sensors





Sensors

an Open Access Journal by MDPI

Impact Factor 3.5 CiteScore 8.2 Indexed in PubMed



About the Journal

Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

Editor-in-Chief

Prof. Dr. Vittorio M. N. Passaro

Dipartimento di Ingegneria Elettrica e dell'Informazione (Department of Electrical and Information Engineering), Politecnico di Bari, Via Edoardo Orabona n. 4, 70125 Bari, Italy

Author Benefits

Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility:

indexed within Scopus, SCIE (Web of Science), PubMed, MEDLINE, PMC, Ei Compendex, Inspec, Astrophysics Data System, and other databases.

Journal Rank:

JCR - Q2 (Instruments and Instrumentation) / CiteScore - Q1 (Instrumentation)

